

# Sense and non-sense of failure rates

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PS Congress 13<sup>th</sup> May 2026

- **RTFM or just store “just in case”?**
- **Failure data IEC 61508 Ed.1 (1999) versus Ed. 2 (2010)**
- **Examples**
- **Proven in use / Prior use**
- **Examples**
- **Systematic Capability**
- **Examples**

Disclaimer: in this presentation we have used examples of existing safety manuals and certificates, we did our best to anonymize company names and persons but could not hide everything. It is not our intent to harm or insult companies or persons in any way.  
We are human beings, human beings make mistakes, we cannot avoid this and we have to accept it. Therefore FSM: reduce or avoid (systematic) failures.

# RTFM or only store for: “just in case”?

- **Safety equipment needs safety specific documentation: safety manuals**
- **Safety manuals belong to lifecycle documentation**
- **What is inside:**
  - **Classification type A or B (simple or complicated devices)**
  - **Failure data ( $\lambda_{SD}$ ,  $\lambda_{SU}$ ,  $\lambda_{DD}$  and  $\lambda_{DU}$ )**
  - **Possible design / application constraints**
  - **Declaration of systematic safety integrity (later)**
- **Instead of filing with the rest of the documentation, give it a read through, you may discover some unexpected things...**
- **Question: who is reading every safety manual?**

# Failure modes and failure rates

**Failure modes for a device are the different ways a device can fail and can be categorized as:**

- **“safe” failure mode means the device can reach safe state or is forced to the safe state**
- **“dangerous” failure mode means the device cannot reach safe state anymore**

**The Failure Rate says something about the frequency of a failure mode of a component or a device. Industrial databases of failure rates per component are available for example: Siemens, TelCordia, MIL handbook etc.**

**Failure rate units differ per database:**

- **per year, per million hours, per billion hours (FIT), years (MTBF)**

By analysing the failure modes of each component, the effect of such failure on the device can be determined. The overall effect can be that the device enters either in the safe or in the dangerous mode.

Adding up all component failure rates with a safe effect results in the safe failure rate of the device:  $\lambda_S$

Adding up all component failure rates with a dangerous effect results in the dangerous failure rate of the device:  $\lambda_D$

FMEA = Failure Modes and Effects Analysis



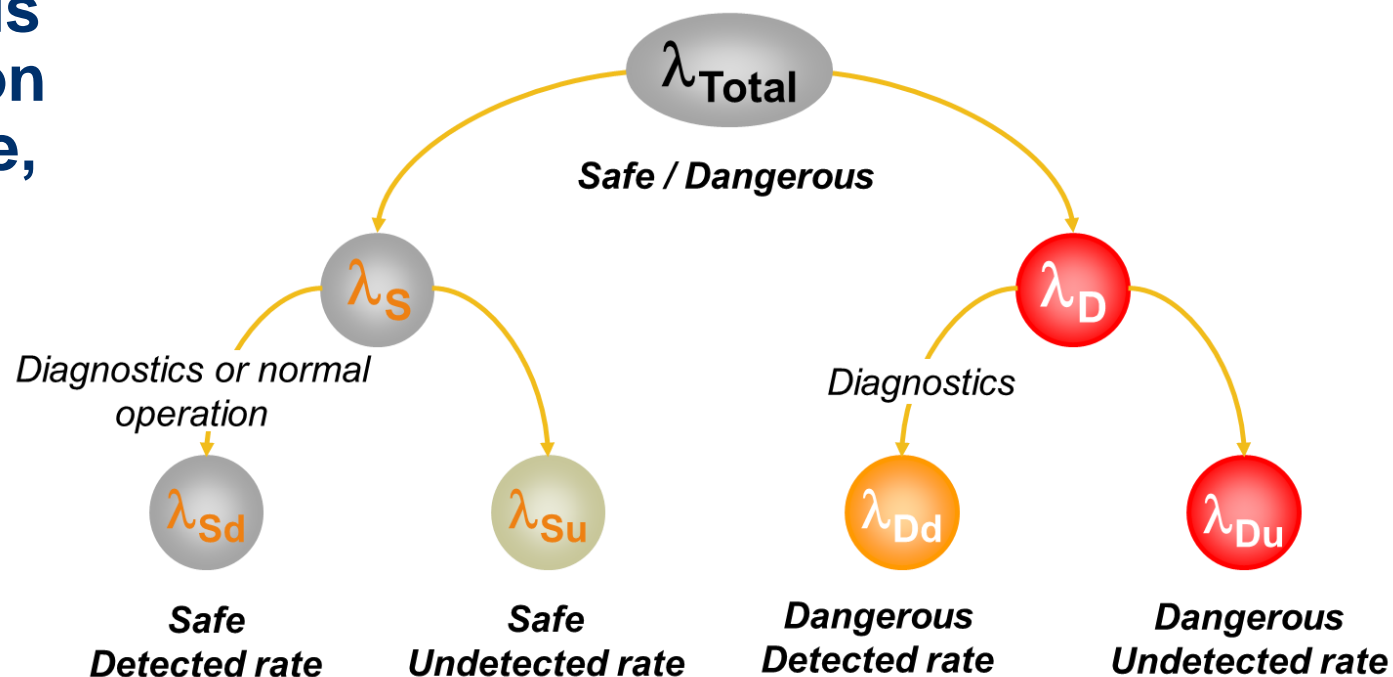
Many devices have internal diagnostics. When diagnostics is applied, failures in a device or system can be revealed. Diagnostics means a periodical/continuous automatic test

When failures are detected various actions can be taken depending on the severity of the detected failure, for example:

- an alarm can be initiated
- the system can be shut down

Now you can do an FMEDA

FMEDA = Failure Modes, Effects and Diagnostic Analysis



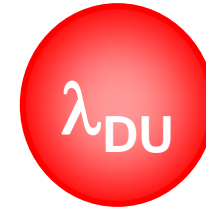
# Failure Rates for safety calculations



**These three don't really bother you :**

**they are detected (so you will repair them) or undetected, but safe anyway.**

**Of course they are not useless: these are used in the calculation of the Availability and the Safe Failure Fraction.**



**This one really bothers you :**

**it will make that the SIF cannot perform the (safety) action.**

**It is the only one that goes into the PFD<sub>AVG</sub> calculation.**

# Safe Failure Fraction

$$\lambda_{SD} + \lambda_{SU} = \lambda_S$$

$$\lambda_{DD}$$

$$\lambda_{DU}$$

$$SFF = \frac{(\lambda_S + \lambda_{DD})}{(\lambda_S + \lambda_{DD} + \lambda_{DU})}$$

IEC61508 Edition 1 (1999) → Safety Manuals started including in  $\lambda_{SU}$  not only “safe undetected” failures but also “No effect”, “No part” etc.

If you increase  $\lambda_{SU}$  artificially: SFF will be close to 100%

Hence by adding components to a device SFF can increase

IEC61508 Edition 2 (2010) → a component that is  $\lambda_{No\ Part}$  or has  $\lambda_{No\ Effect}$  on the SIF can not be part of SFF calculation anymore

# Example 1: what do we see?

Certificate / Certificat

Valid until December 1, 2017  
Revision 1.5 December 5, 2014

Has been assessed per the relevant requirements of:

**IEC 61508 : 2000 Parts 1-7**

and meets requirements providing a level of integrity to:

**Systematic Capability: SC 3 (SIL 3 Capable)**

**Random Capability: Type B Element**

**SIL 2 @ HFT=0; SIL 3 @ HFT = 1; Route 1<sub>H</sub>**

**PFD<sub>AVG</sub> and Architecture Constraints  
must be verified for each application**

ANSI

ANSI Accredited Program  
PRODUCT CERTIFICATION  
#1004

Certifying Assessor

Page 1 of 2

# Example 2a: what do we see?

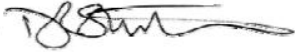
This is to certify that the  
**A90RL Ball Valve**  
manufactured by  
**SRI Engineering**  
279-305 Bd Danielle Casanova  
BP. 316  
13309  
MARSEILLE  
FRANCE

has been assessed by \_\_\_\_\_ with reference to the  
CASS methodologies and found to meet the requirements of  
**IEC 61508-2:2010**

The Product and its associated data contained herein can be considered for use in the  
design of safety functions up to and including  
**SIL 2\* (without PVST)**  
**SIL 3\* (with PVST)**

when used in accordance with the scope and conditions of this certificate.

\* The Product that has been certified is not implicit of the achieved Safety Integrity  
Level (SIL) of the safety related system

Certification Manager:   
D Stubbings

Initial Certification: 13<sup>th</sup> July 2012  
This certificate issued: 13<sup>th</sup> July 2012  
Renewal date: 12<sup>th</sup> July 2017

This certificate may only be reproduced in its entirety, without any change.

- Did the design change?
- Without PVST your  $\lambda_{DD}$  is to be added to  $\lambda_{DU}$ , you cannot improve  $\lambda_{DU}$  with your PVST coverage factor!


- SIL4 also implies SC4 (see later!)
- Forget SIL3 for single valves, with only a few exceptions

This is to certify that the  
**A90RL Ball Valves**  
manufactured by  
**Sud Robinetterie Industrie**  
279-305 boulevard Danielle Casanova  
13014 Marseille  
FRANCE

has been assessed by \_\_\_\_\_ with reference to the  
CASS methodologies and found to meet the requirements of  
**IEC 61508-2:2010**  
as an element/subsystem suitable for use in safety related systems performing safety  
functions up to and including  
**SIL 3\* (without PVST)**  
**SIL 4\* (with PVST)**

when used in accordance with the scope and conditions of this certificate.

\* This certificate does not waive the need for further functional safety verification to  
establish the achieved Safety Integrity Level (SIL) of the safety-related system.

Certification Manager:   
James Lynskey

Initial Certification: 14/06/2021  
This certificate issued: 01/07/2021  
Renewal date: 02/11/2026

# Example 2b: what do we see?

## Product description and scope of certification

### Product Identification: A90RL Series Ball Valve

SAFETY FUNCTION:  
'To ensure the Normally Open Valve Closes in response to Actuation'

Architectural constraints:	Type A SFT=0; (1001) SF=73.19%	SIL2
Random hardware failures:	$\lambda_{DD} = 0$ $\lambda_{DU} = 6.98E-07$	$\lambda_{SD} = 0$ $\lambda_{SU} = 1.91E-06$
Probability of failure on demand:	PFD <sub>LD</sub> = 3.00E-03 (Low Demand Mode)	Assuming: - PTI = 8.60 <sup>[4]</sup> MTTR = 8Hrs <sup>[4]</sup>
Hardware safety integrity compliance <sup>[1]</sup>		Route 1 <sub>H</sub>
Systematic safety integrity compliance <sup>[1]</sup>		Route 1 <sub>S</sub>
Systematic Capability <sup>[2]</sup>		SC 2
Overall SIL-capability achieved <sup>[3]</sup>		SIL 2 (Low Demand)

If a device is suitable for SIL3 (with partial stroke testing), then the manufacturer shall have an FSM system in place with SC3 (will come back)

Safety manual 2012, page 2

# Example 2c: what do we see?

## Product description and scope of certification

## Safety manual 2021, page 2

**Table1:** Summary of assessment for the A90RL Ball Valves in HFT=0 configurations.

Parameter name	Symbol	1001 HFT=0 PTI = 6 month	1001 HFT=0 PTI = 1 year	2002 HFT=0 PTI = 6 month	2002 HFT=0 PTI = 1 year
Hardware Fault Tolerance	HFT	0	0	0	0
Proof Test Interval	T	4380 (6 Month)	8760 (1 year)	4380 (6 month)	8760 (1 year)
Mean Time To Repair	MTTR	3	3	3	3
Type A/B	Type A	Type A	Type A	Type A	Type A
Dangerous undiagnosed failures	$\lambda_{DU}$	6.47E-10	6.47E-10	6.47E-10	6.47E-10
PFD <sub>AVG</sub>	PFD <sub>AVG</sub>	1.42E-10	2.83E-10	4.25E-10	8.50E-10
SIL capability (Low demand mode)		SIL 5	SIL 5	SIL 3	SIL 3

**Table 2:** Summary of assessment for the A90RL Ball Valves in HFT=1 configurations.

Parameter name	Symbol	1002 HFT=1 PTI = 6 month	1002 HFT=1 PTI = 1 year	2003 HFT=1 PTI = 6 month	2003 HFT=1 PTI = 1 year
Hardware Fault Tolerance	HFT	1	1	1	1
Proof Test Interval	T	4380 (6 Month)	8760 (1 year)	4380 (6 month)	8760 (1 year)
Mean Time To Repair	MTTR	3	3	3	3
Type A/B	Type A	Type A	Type A	Type A	Type A
Dangerous undiagnosed failures	$\lambda_{DU}$	6.47E-11	6.47E-11	1.25E-10	1.25E-10
PFD <sub>AVG</sub>	PFD <sub>AVG</sub>	1.47E-10	2.83E-10	2.83E-10	5.67E-10
SIL capability (Low demand mode)		SIL 4	SIL 4	SIL 3	SIL 3

- Where did PVST go??
- $PFD_{1001} = \frac{1}{2} \lambda_{DU} \times t = 2.83e^{-6}$
- $\lambda_{DU}$  and  $PFD_{AVG}$  improved a factor  $10^3$  compared with 2012
- HFT=1  $\lambda_{DU}$  and  $PFD_{AVG}$  improve factor  $10^3$  compared with 2012
- $PFD_{AVG}$  in SIL 5 bandwidth?
- $PFD_{1002} = (\lambda_{DU}^2 \times t^2)/3 = 1.07e^{-11}$
- $PFD_{2003} = \text{not possible}$
- MTTR = 3 hrs

So, in case of detected fault, process stopped, valve removed, repaired, replaced, retested in 3 hours?

# Example 3: what do we see?

*Engineering For The Future*

## **DECLARATION OF CONFORMITY**

This is to certify that the Solenoid Valve 24102 is meeting the requirement of SIL - LEVEL 2 as per guidelines of EN- 61508.

PFD value of the valve is  $< 9 \times 10^{-5}$  at confidence interval of 90%.

The SFF according to Table A-1, IEC 61508-2 is Greater or Equal to 0.82.

Signature of the Manufacturer

Manager - Quality

INDIA

**CERTIFICATE**

- Date ?? → IEC 61508 Ed1 or Ed 2?
- PFD  $< 9e-5$  → SIL4?? @ proof test interval?
- Confidence interval??
- Type A or type B device ??
- SFF according table A.1 IEC 61508 part 2

61508-2 © IEC:2010

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**Table A.1 – Faults or failures to be assumed when quantifying the effect of random hardware failures or to be taken into account in the derivation of safe failure fraction**

Component	See table(s)	Requirements for diagnostic coverage claimed		
		Low (60 %)	Medium (90 %)	High (99 %)
<b>Electromechanical devices</b>	A.2	Does not energize or de-energize Welded contacts	Does not energize or de-energize Individual contacts welded	Does not energize or de-energize Individual contacts welded No positive guidance of contacts (for relays this failure is not assumed if they are built and tested according to EN 50205 or equivalent) No positive opening (for position switches this failure is not assumed if they are built and tested according to IEC 60947-5-1, or equivalent)

# Example 4: what do we see?

## Useful Lifetime

A time of usage of more than 5 years (+ 1.5 years of storage) can only be favoured under responsibility of the operator, consideration of specific external conditions (securing of required quality of media, max. temperature, time of impact), and adequate test cycles. Please consider the references in the Safety Manual according test intervals and procedures as well as maintenance in respect with the useful lifetime , including the possibility of longer periods of use.

## Translation:

- **After 5 years (or 6.5 incl. storage) it is not our responsibility anymore**
- **We recommend replacement every 5 years...**

# HFT assessment – 3 routes

1. IEC 61508 Route 1H based on SFF
2. IEC 61508 Route 2H based on field experience (proven in use)
3. IEC 61511 based on field experience (prior use)

## IEC 61508 Route 1H (SFF based)

**Table 2 — Hardware safety integrity:  
architectural constraints on type A  
safety-related subsystems**

Safe failure fraction	Hardware fault tolerance		
	0	1	2
< 60 %	SIL1	SIL2	SIL3
60 % - < 90 %	SIL2	SIL3	SIL4
90 % - < 99 %	SIL3	SIL4	SIL4
> 99 %	SIL3	SIL4	SIL4

**Type A: simple devices**

**Table 3 — Hardware safety integrity:  
architectural constraints on type B  
safety-related subsystems**

Safe failure fraction	Hardware fault tolerance		
	0	1	2
< 60 %	not allowed	SIL1	SIL2
60 % - < 90 %	SIL1	SIL2	SIL3
90 % - < 99 %	SIL2	SIL3	SIL4
> 99 %	SIL3	SIL4	SIL4

**Type B: complicated devices**

# Based on field experience

**IEC 61508 Route 2H (proven in use)**

**IEC 61511 (prior use)**

**IEC 61508 - failure data must be:**

- based on feedback from field operation in a similar application and environment
- collected in accordance with international standards
- evaluated and judged by expert

**IEC 61511 – failure data formulated slightly different:**

- also based on similar operating environments.

SIL		Minimum Hardware Fault Tolerance (see clause 7.4.4.3)
1	any mode	0
2	low demand mode	0
2	high demand or continuous mode	1
3	any mode	1
4	any mode	2

# Who can really claim proven in use / prior use ?

Who has the overview of:

- the total number of the (same) devices
- same application, same environment
- maintenance records, failure records
- all this for many years

**The End User!**

Do manufacturers know:

- where their hardware eventually is installed (Arctic vs. Desert)
- how correct maintenance is done
- if replacement is done without their knowing
- all this for many years

**NO!!!**

# Example - Valves: market is flooded with 2H certificates

## Why are they successful?

- if it looks official enough, people believe everything...
- from “trustworthy” companies
- people do not read the certificates anymore...



**Safety  
Certificate  
page 1**



Certificate / Certificat  
Zertifikat / 合格証

ASC 1301001 C005

*exida* hereby confirms that the:

**Series 551 and 553 Pilot Operated  
Inline Spool Valves**

**ASCO Numatics  
Lucé, France**

Have been assessed per the relevant requirements of:

**IEC 61508 : 2010 Parts 1-7**

and meets requirements providing a level of integrity to:

**Systematic Capability: SC 3 (SIL 3 Capable)**

**Random Capability: Type A, Route 2<sub>H</sub> Device**

**PFD<sub>AVG</sub> and Architecture Constraints  
must be verified for each application**

**Safety Function:**

The Valve will move to the designed safe position when de-energized within the specified safety time.

# Example - Valves: market is flooded with 2H certificates

**Systematic Capability: SC 3 (SIL 3 Capable)**

**Random Capability: Type A, Route 2<sub>H</sub> Device**

**PFD<sub>AVG</sub> and Architecture Constraints must be verified for each application**

## Systematic Capability :

These products have met manufacturer design process requirements of Safety Integrity Level (SIL) 3. These are intended to achieve sufficient integrity against systematic errors of design by the manufacturer.

A Safety Instrumented Function (SIF) designed with these products must not be used at a SIL level higher than stated.

## Random Capability:

The SIL limit imposed by the Architectural Constraints must be met for each element. This device meets *exida* criteria for Route 2<sub>H</sub>.

**Do you read the small letters?**

**So not the IEC 61508 Ed2 criteria but some “home-made” requirements instead...**

***And the people that do read and understand the IEC standards feel like fighting windmills***

## Safety Certificate page 2



### Key Exida Criteria for Proven in Use

- **Operational History:** Extensive field data demonstrating the device has been used successfully in similar environments and applications.
- **Field Data Accuracy:** A documented and maintained quality system for collecting field return data to ensure data accuracy.
- **Failure Analysis:** A rigorous assessment to prove the absence of systematic faults, including a review of revision history.
- **Data Sufficiency:** Sufficient hours must be documented to support the required safety integrity level.
- **IEC 61508 Requirements:** The evidence demonstrate that the device complies with the requirements of IEC 61508, or specifies 4.1 for user-driven prior use, to be considered for use in a safety-instrumented

This is 114155 years...

### Route 2H Focus

- **Exida often uses a 2H approach**, requiring over 1,000,000,000 unit operating hours in field failure data for all components.
- The device should typically have a diagnostic coverage (for dangerous failures) of 60% or more, particularly for Type B components.
- No new technology (i.e., components lacking extensive field history) should be present. exida +1

# Systematic Safety Integrity – Systematic Capability

Three basic requirements have to be fulfilled in order to claim any SIL:

1.  $PFD_{AVG}$  of the SIF shall be within the target SIL bandwidth.
2. Hardware fault tolerance (HFT) for the target SIL to be justified.  
**Hardware safety integrity**
3. Systematic Capability shall comply with the requirements for the target SIL  
**Systematic safety integrity**

SC is a measure of the quality of the (manufacturer's) organization and its Functional Safety Management system. It is expressed as SC1 to SC4 and must correspond with the (highest) target SIL.

# Who shall prove Systematic Capability?

**Systematic Capability is determined by the applied Functional Safety Management (FSM) in an FSM system for:**

- 1. The manufacturers of all bought-in devices in the (pipe to pipe) SIF:  
Declaration of manufacturer is needed (or from certification body).**
- 2. For all parties involved in the safety life cycle (End User, EPC, SIS integrator etc.) .**

**Systematic Capability is determined by the applied FSM:**

- Have an FSM system in place which is regularly audited by someone with the correct independence. The higher the required SIL level, the more independence is required (independent department/organization).**
- Audit report to draw a conclusion on the achieved systematic safety integrity (SC).**

# Example - Systematic Capability understood?

Document No R&P- SIL Safety Manual

Document Issue: Rev 02

Date of Issue: 07 October 2020

SIL Safety Manual

## 12. SYSTEMATIC CAPABILITY

The systematic capability of the device is 3.

This systematic capability is guaranteed only if the user:

- Use the device according to the instructions for use and to the present Manual.
- Use the device in the appropriate environment (limitation of use).

### 3.6 Systematic integrity

Systematic integrity requirements according IEC 61508 up to and including Safety Integrity level (SIL) 3 are fulfilled. These requirements include adequate integrity against systematic errors in the product design, and controlling systematic failures in the selection and manufacturing process. Series 5000, 6000, 7000, 9000 flanged ball valves must not be used in safety integrity functions with higher than the stated SIL level without a provision in use statement or, in some cases, redundant designs.

# With this knowledge, can you tell me?

**My Japanese colleague designed a new transmitter and asks me what to do to make it a SIL transmitter.**

**What will be my 3 answers?**

- 1. Do an FMEDA. (for the  $\lambda_{SD}$   $\lambda_{SU}$   $\lambda_{DD}$  and  $\lambda_{DU}$   $\rightarrow$   $PFD_{AVG}$  and SFF**
- 2. Setup an FSM system for your design and manufacturing organization to prove SC.**

**Then it becomes very silent...**

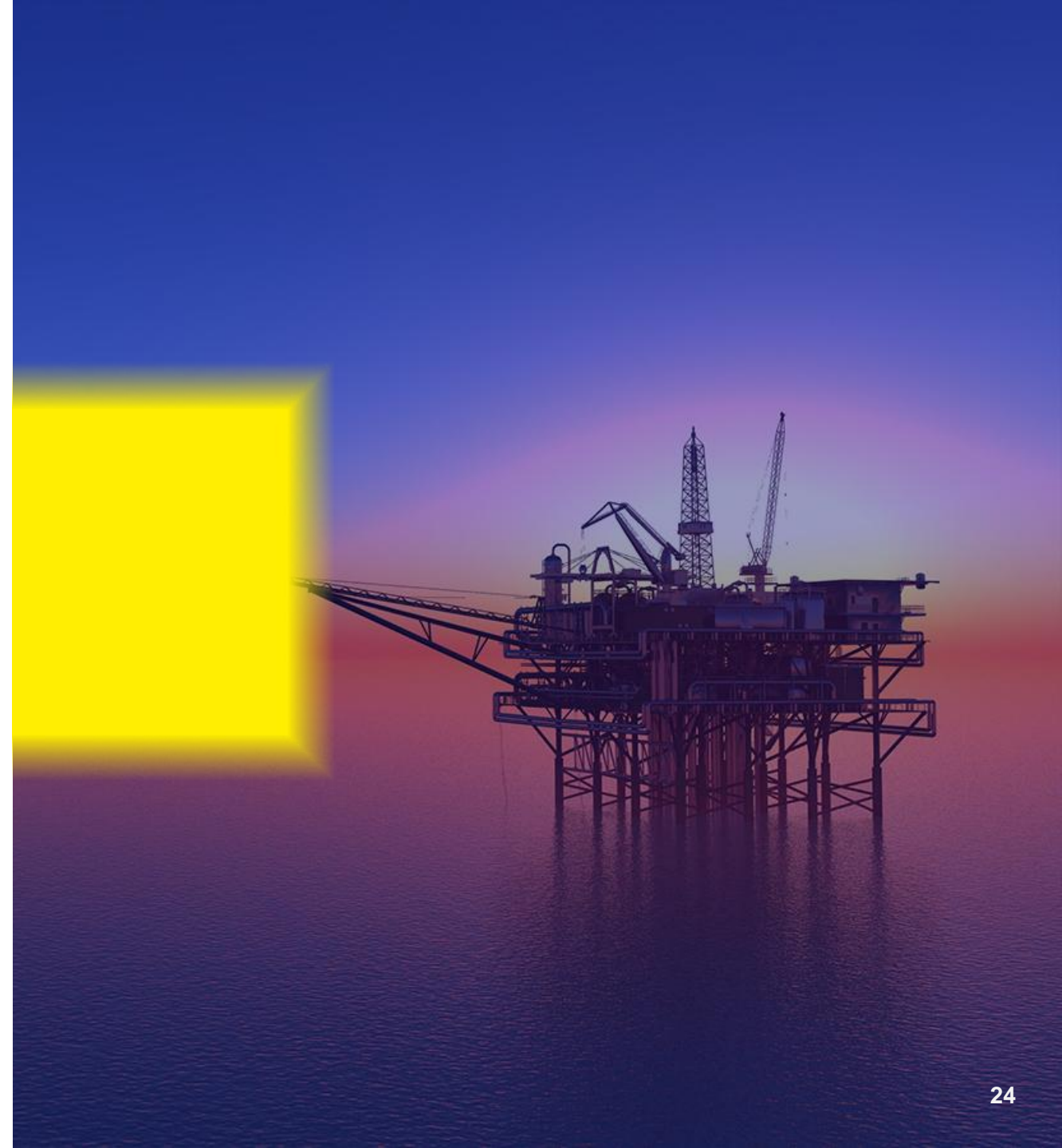
- 3. Or, talk to your colleagues who designed the EJX transmitter, they have already done it...**

# Any questions ?

Co-innovating tomorrow™

Want to know more?

- Visit us on our stand
- Come to our **Safety event** in Amersfoort on 24<sup>th</sup> June





TON  
BEEMS



DAVE  
VAN DEN HAM



ARJEN  
DE KONING



CLAUDY  
DE GROOTE

JOIN US



**Safety inspiration in-depth session**

June 24 2026, 09:30-13:00, Amersfoort